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MS ISSUE FEE
PATENT
0020-5222P

IN THE U.S. PATENT AND TRADEMARK OFFICE

Applicant: Kei TOKUI et al. Group: 2822
Application No.: 10/770,627 Examiner: Ida M. Soward
Filed: February 2, 2004 Conf. No.: 2315
For: SEMICONDUCTOR STORAGE DEVICE

LETTER REQUESTING INITIALED PTO 1449 FORM

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

JUN 22 2005

Sir:

In reviewing the above-captioned application file, the undersigned has noted that even though the Examiner initialed the PTO 1449 Form filed on February 4, 2004, there is a line crossed through one of the references. An explanation was not given as to why this reference was not considered.

The Patent and Trademark Office therefore is requested to return the initialed form without the strike-through line to the undersigned as soon as possible.

If necessary, the Commissioner is hereby authorized in this, concurrent, and future replies, to charge payment or credit any overpayment to Deposit Account No. 02-2448 for any additional fees required under 37 C.F.R. §1.16 or under 37 C.F.R. §1.17; particularly, extension of time fees.

Respectfully submitted,

BIRCH, STEWART, KOLASCH & BIRCH, LLP

By 
TERRELL C. BIRCH, #19,382

RWD
TCB/RWD/djm

P.O. Box 747
Falls Church, VA 22040-0747
(703) 205-8000



Form PTO-1449 INFORMATION DISCLOSURE CITATION IN AN APPLICATION <small>(Use several sheets if necessary)</small>				ATTY. DOCKET NO. 0020-5222P		APPLICATION NO. NEW 10/779,627			
				APPLICANT TOKUI, Kei et al					
				FILING DATE February 4, 2004		GROUP 2822			
U.S. PATENT DOCUMENTS									
EXAMINER INITIAL	DOCUMENT NUMBER	Kind	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE		
/	US								
	US								
	US								
	US								
	US								
	US								
FOREIGN PATENT DOCUMENTS									
	Office	DOCUMENT NUMBER	Kind	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION	
								YES	NO
/	JP	2001-156188	A	2001-06-08	JAPAN			ABS	
	JP	2001-230332	A	2001-08-24	JAPAN			ABS	
/	JP	9-116119	A	1997-05-02	JAPAN			ABS	
	JP	2001-512290	A	2001-08-21	JAPAN				
/	WO	99/07000	A2	1999-02-02	WO			ABS	
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/	WO	03/103058	A1	2003-12-11	WO			ABS	
	JP	5-304277	A	1993-11-16	JAPAN			ABS	
/	JP	5-81702	B2	1993-11-15	JAPAN				
	OTHER DOCUMENTS (Include Name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.) date, page(s), volume-issue number(s), publisher, city and/or country where published.)								
EXAMINER <i>John M. Soward</i>					DATE CONSIDERED <i>3-23-05</i>				
<small>EXAMINER: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>									